

650V N-Channel Super Junction Power MOSFET

DESCRIPTION

The **65R900D** use advanced super junction technology and design to provide excellent RDS(ON) with low gate charge. This super junction MOSFET fits the industry's AC-DC SMPS requirements for PFC, AC/DC power conversion, and industrial power applications.

FEATURES

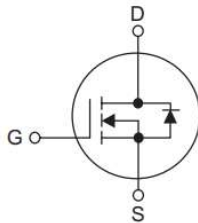
- * New technology for high voltage device
- * 100% avalanche tested
- * Low on-resistance and low conduction losses
- * Ultra low gate charge cause lower driving requirements



TO-252

SYMBOL

1. Gate
2. Drain
3. Source



Package Description

Product Model	Package Type	Mark Name	Indentification Code	Package
CMS65R900D	TO-252	CMS65R900	D	Tape Reel

CMS65R900D

(2) Package type

(1) Chip name

(1) CMS65R900D: 650V 5A (2) D:TO-252

ABSOLUTE MAXIMUM RATINGS ($T_C = 25^\circ\text{C}$, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V_{DSS}	650	V
Gate-Source Voltage		V_{GSS}	± 30	V
Drain Current	Continuous($T_C=25^\circ\text{C}$)	I_D	5.0	A
	Continuous($T_C=100^\circ\text{C}$)		3.0	A
Drain Current	Pulsed (Note1)	I_{DM}	15	A
Avalanche Energy	Single Pulsed (Note2)	E_{AS}	135	mJ
Repetitive Avalanche Energy (Note1)		E_{AR}	0.4	mJ
Drain Source voltage slope, $V_{DS} \leq 480\text{ V}$		dv/dt	48	V/ns
Power Dissipation	$T_C=25^\circ\text{C}$	PD	49	W
	TO-252			
Junction Temperature		T_J	+150	$^\circ\text{C}$
Storage Temperature		T_{STG}	-55~+150	$^\circ\text{C}$

Notes:

- 1、Repetitive Rating:Pulse Width Limited by Maximum Junction Temperature.
- 2、 $T_J = 25^\circ\text{C}$, $V_{DD} = 50\text{V}$, $V_G = 10\text{V}$, $R_G = 25\ \Omega$

THERMAL CHARACTERISTICS

Symbol	Parameter	PACKAGE	RATINGS	Units
$R_{\theta JC}$	Junction-to-Case	TO-252	2.55	$^\circ\text{C/W}$
$R_{\theta JA}$	Junction-to-Ambient	TO-252	75	$^\circ\text{C/W}$

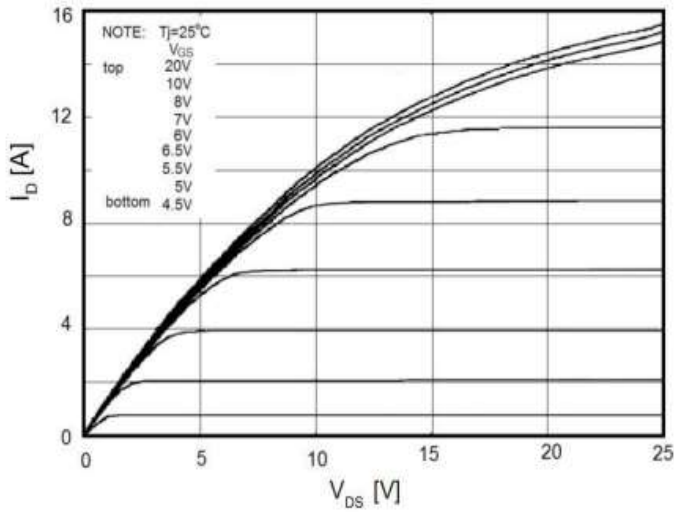
ELECTRICAL CHARACTERISTICS ($T_C = 25^\circ\text{C}$, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage	$B_{V_{DS}}$	$V_{GS} = 0\text{ V}, I_D = 250\mu\text{A}$	650			V	
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 650\text{ V}, V_{GS} = 0\text{ V}$			1	μA	
Gate-Source Leakage Current	Forward	I_{GSS}			100	nA	
	Reverse						$V_{GS} = -30\text{ V}, V_{DS} = 0\text{ V}$
ON CHARACTERISTICS							
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$	2.0		4.0	V	
Static Drain-Source On- Resistance	$R_{DS(ON)}$	$V_{GS} = 10\text{ V}, I_D = 2.5\text{A}$		780	900	$\text{m}\Omega$	
DYNAMIC CHARACTERISTICS							
Input Capacitance	C_{ISS}	$V_{DS} = 50\text{ V}, V_{GS} = 0\text{V}, f = 1.0\text{MHz}$		460		pF	
Output Capacitance	C_{OSS}				45		pF
Reverse Transfer Capacitance	C_{RSS}				3.5		pF
SWITCHING CHARACTERISTICS							
Total Gate Charge	Q_G	$V_{DS} = 480\text{V}, I_D = 5\text{A}, V_{GS} = 10\text{V}$		10		nC	
Gate-Source Charge	Q_{GS}			1.6		nC	
Gate-Drain Charge	Q_{GD}			4		nC	
Turn-On Delay Time	$t_{D(ON)}$	$V_{DS} = 380\text{V}, I_D = 2.5\text{A}, R_G = 18\Omega, V_{GS} = 10\text{V}$		6		ns	
Turn-On Rise Time	t_R			3		ns	
Turn-Off Delay Time	$t_{D(OFF)}$			50		ns	
Turn-Off Fall Time	t_F			9		ns	
Drain-Source Diode Characteristics and Maximum Ratings							
Maximum Continuous Drain-Source Diode Forward Current	I_{SD}				5	A	
Maximum Pulsed Drain-Source Diode Forward Current	I_{SM}				15	A	
Drain-Source Diode Forward Voltage	V_{SD}	$T_J = 25^\circ\text{C}, V_{GS} = 0\text{ V}, I_{SD} = 5\text{A}$			1.2	V	
Reverse Recovery Time	t_{rr}	$T_J = 25^\circ\text{C}, I_S = 5\text{A}, dI_F/dt = 100\text{ A}/\mu\text{s}$		250		ns	
Reverse Recovery Charge	Q_{rr}				2.2		μC

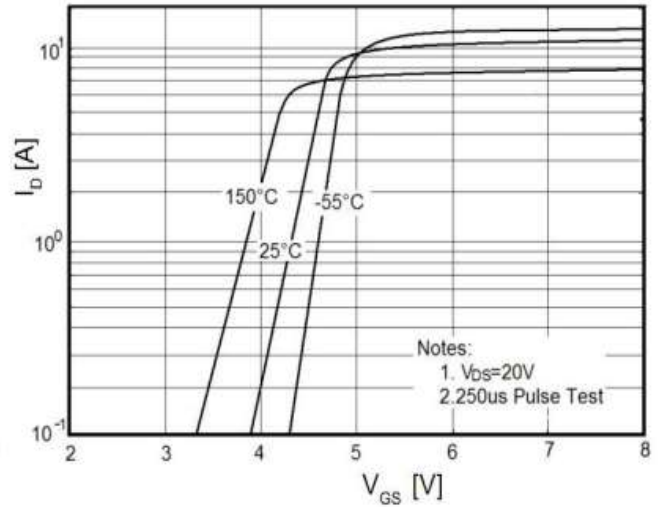
Drain Current Limited by Maximum Junction Temperature.

YPICAL CHARACTERISTICS

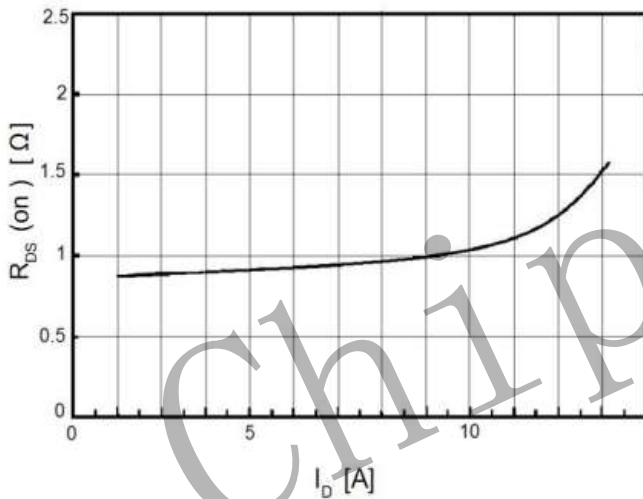
On-Regin Characteristics



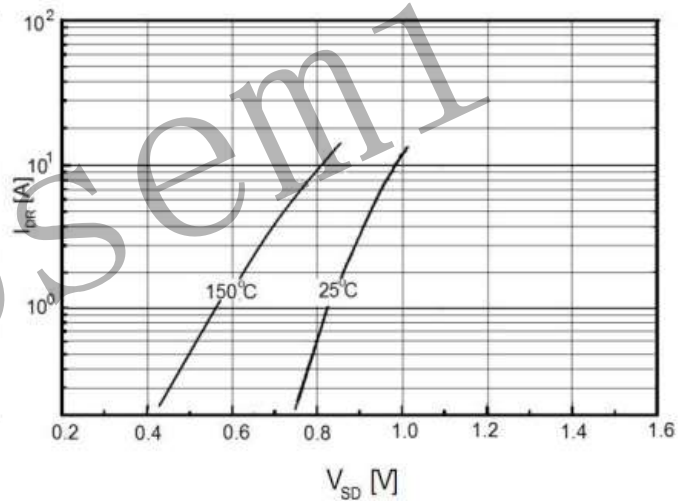
Transfer Characteristics



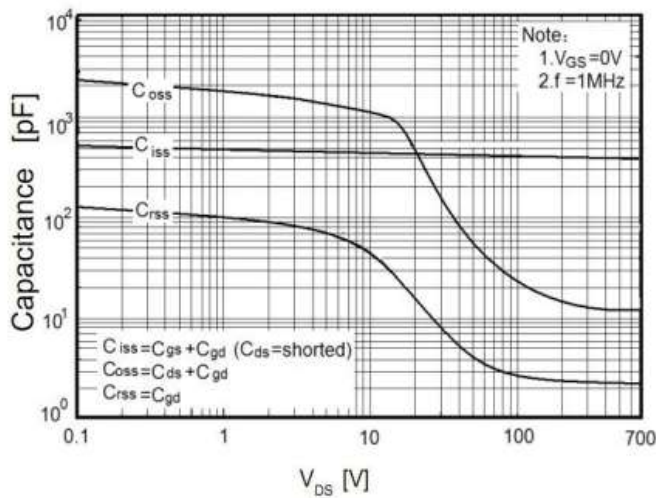
On-Resistance Variation vs. Drain Current and Gate Voltage



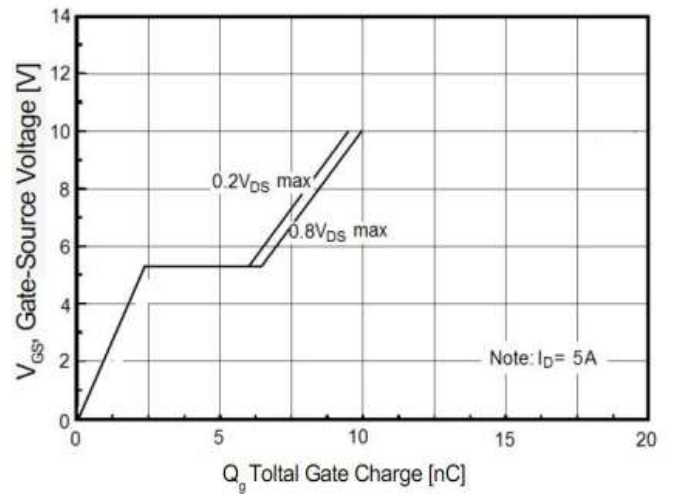
Body Diode Forward Voltage Variation vs. Source Current and Temperature



Capacitance Characteristics

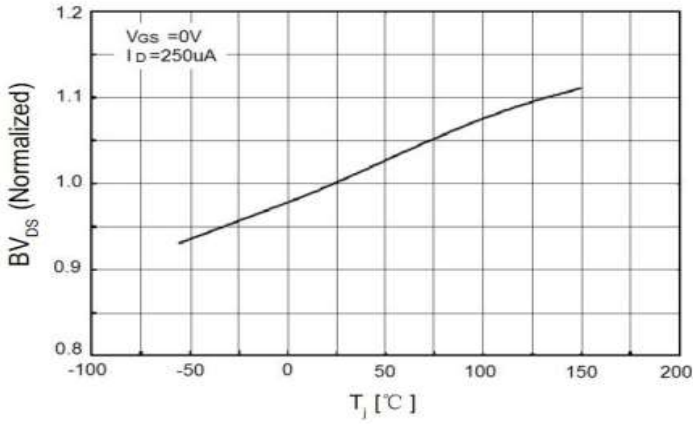


Gate Charge Characteristics

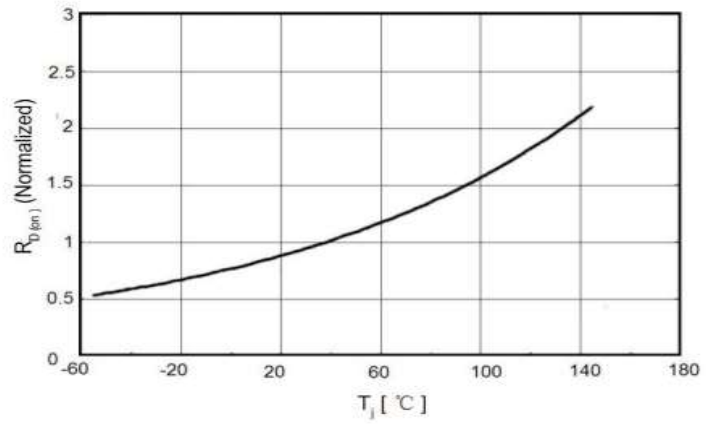


TYPICAL CHARACTERISTICS (Cont.)

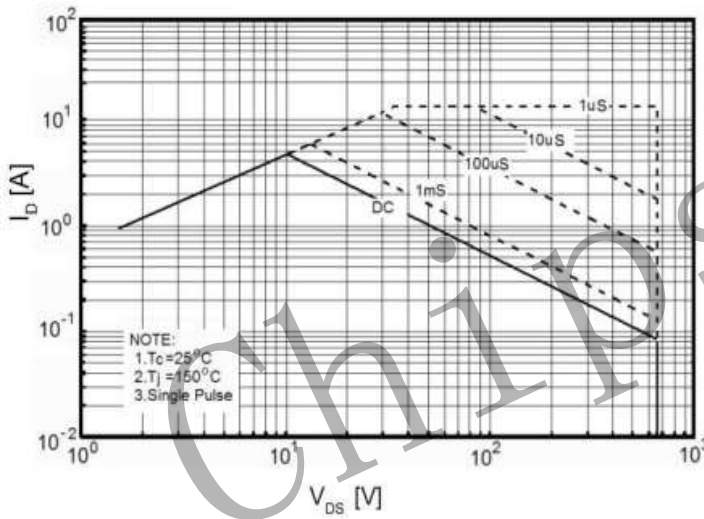
Breakdown Voltage Variation
vs. Temperature



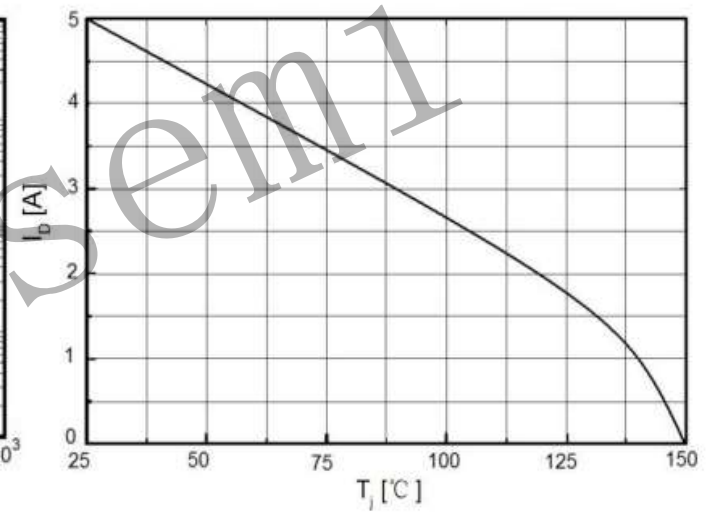
On-Resistance Variation
vs. Temperature



Maximum Safe Operating Area



Maximum Drain Current
Vs. Case Temperature



Attentions

- Exceeding the maximum ratings of the device in performance may cause damage to the device, even the permanent failure, which may affect the dependability of the machine. Please do not exceed the absolute maximum ratings of the device when circuit designing.
- When installing the heat sink, please pay attention to the torsional moment and the smoothness of the heat sink.
- MOSFET is the device which is sensitive to the static electricity, it is necessary to protect the device from being damaged by the static electricity when using it.
- Chipsemi reserves the right to make changes in this specification sheet and is subject to change without prior notice.

Appendix

Revision history:

Date	REV.	Description	Page
2023.3	1.0	Original	6

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